Search Notes

Appl	licatio	n/Con	trol	No.

10/076,455 Examiner

Hoan H. Tran

Applicant(s)/Patent under Reexamination

YAMADA ET AL.

Art Unit

2852

	SEARCHED				
Class	Subclass	Date	Examiner		
399	254	6/23/2005	нт		
399	256	6/23/2005	нт		
399	258	6/23/2005	нт		
399	262	6/23/2005	нт		
399	263	6/23/2005	нт		
366	241	6/23/2005	нт		
366	244	6/23/2005	нт		
366	279	6/23/2005	HT		
222	DIG.1	6/23/2005	нт		
222	167	6/23/2005	нт		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
399	262	6/23/2005	нт		
399	263	6/23/2005	нт		
222	DIG.1	6/23/2005	нт		
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See attachment	6/23/2005	нт